

**Search Notes**

Application/Control No.

10/533,266

Examiner

Bin Shen

Applicant(s)/Patent under  
Reexamination

FREEMAN, MATTHEW

Art Unit

1657

**SEARCHED**

Class	Subclass	Date	Examiner
NA	NA	11/22/2006	BS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN/WEST--see printout.	11/22/2006	BS
Priority document and references checked.	11/22/2006	BS
Inventor name searched.	11/22/2006	BS
SEQ IDs Checked.	11/22/2006	BS